


<b>Search Notes</b> 	<b>Application/Control No.</b> 10614997	<b>Applicant(s)/Patent Under Reexamination</b> BURKE ET AL.
	<b>Examiner</b> PHUNG M CHUNG	<b>Art Unit</b> 2117

SEARCHED			
Class	Subclass	Date	Examiner
714	724-725,733-734,10,11,30,38,742,740,776	4/26/09	pmc
702	118	4/26/09	pmc
716	4	4/26/09	pmc

SEARCH NOTES		
Search Notes	Date	Examiner
Interference searched see print out	4/26/09	pmc

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
714	724	4/26/09	pmc
702	118	4/26/09	pmc

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